



**12500 TI Boulevard, MS 8640, Dallas, Texas 75243**

**PCN# 20191112001.1**

**Qualification of RFAB as an additional Fab site option for select devices and  
Datasheet Update  
Change Notification / Sample Request**

**Date:** November 18, 2019

**To:** TOKYO ELECTRON DEVICE (DSTR) PCN

Dear Customer:

This is an announcement of a change to a device that is currently offered by Texas Instruments. The details of this change are on the following pages.

Texas Instruments requires acknowledgement of receipt of this notification within **30** days of the date of this notice. Lack of acknowledgement of this notice within 30 days constitutes acceptance of the change. If samples or additional data are required, requests must be received within **30 days** of this notification.

The changes discussed within this PCN will not take effect any earlier than the proposed first ship date on Page 3 of this notification, unless customer agreement has been reached on an earlier implementation of the change.

This notice does not change the end-of-life status of any product. Should product affected be on a previously issued product withdrawal/discontinuance notice, this notification does not extend the life of that product or change the life time buy offering/discontinuance plan.

For questions regarding this notice or to provide acknowledgement of this PCN, you may contact your local Field Sales Representative or the PCN Team ([PCN\\_ww\\_admin\\_team@list.ti.com](mailto:PCN_ww_admin_team@list.ti.com)). For sample requests or sample related questions, contact your local Field Sales Representative.

PCN Team  
SC Business Services


**20191112001.1**  
**Attachment: 1**

**Products Affected:**

The devices listed on this page are a subset of the complete list of affected devices. According to our records, these are the devices that you have purchased within the past twenty-four (24) months. The corresponding customer part number is also listed, if available.

<b>DEVICE</b>	<b>CUSTOMER PART NUMBER</b>
TPS63020DSJR	null
TPS63021DSJT	null
TPS63020DSJT	null
TLV62080DSGR	null
TPS62080DSGR	null
TPS62080DSGT	null
TLV62084DSGR	null
TLV62084DSGT	null
TLV62080DSGT	null

Technical details of this Product Change follow on the next page(s).

<b>PCN Number:</b>	20191112001.1		<b>PCN Date:</b>	Nov 18, 2019																			
<b>Title:</b>	Qualification of RFAB as an additional Fab site option for select devices and Datasheet Update																						
<b>Customer Contact:</b>	<a href="#">PCN Manager</a>		<b>Dept:</b>	Quality Services																			
<b>Proposed 1<sup>st</sup> Ship Date:</b>	Feb 18, 2020		<b>Estimated Sample Availability:</b>	Date provided at sample request.																			
<b>Change Type:</b>																							
<input type="checkbox"/>	Assembly Site	<input type="checkbox"/>	Assembly Process	<input type="checkbox"/>	Assembly Materials																		
<input type="checkbox"/>	Design	<input checked="" type="checkbox"/>	Electrical Specification	<input type="checkbox"/>	Mechanical Specification																		
<input type="checkbox"/>	Test Site	<input type="checkbox"/>	Packing/Shipping/Labeling	<input type="checkbox"/>	Test Process																		
<input type="checkbox"/>	Wafer Bump Site	<input type="checkbox"/>	Wafer Bump Material	<input type="checkbox"/>	Wafer Bump Process																		
<input checked="" type="checkbox"/>	Wafer Fab Site	<input checked="" type="checkbox"/>	Wafer Fab Materials	<input type="checkbox"/>	Wafer Fab Process																		
		<input type="checkbox"/>	Part number change																				
<b>Notification Details</b>																							
<b>Description of Change:</b>																							
Texas Instruments is pleased to announce the qualification of its RFAB fabrication facility as an additional Wafer Fab source for the selected devices listed in the "Product Affected" section.																							
<table border="1"> <thead> <tr> <th colspan="3">Current Fab Site</th> <th colspan="3">Additional Fab Site</th> </tr> <tr> <th>Current Fab Site</th> <th>Process</th> <th>Wafer Diameter</th> <th>New Fab Site</th> <th>Process</th> <th>Wafer Diameter</th> </tr> </thead> <tbody> <tr> <td>FFAB</td> <td>LBC7</td> <td>200 mm</td> <td>RFAB</td> <td>LBC7</td> <td>300 mm</td> </tr> </tbody> </table>						Current Fab Site			Additional Fab Site			Current Fab Site	Process	Wafer Diameter	New Fab Site	Process	Wafer Diameter	FFAB	LBC7	200 mm	RFAB	LBC7	300 mm
Current Fab Site			Additional Fab Site																				
Current Fab Site	Process	Wafer Diameter	New Fab Site	Process	Wafer Diameter																		
FFAB	LBC7	200 mm	RFAB	LBC7	300 mm																		
As part of the RFAB qualification, it was determined that the previous Datasheet ESD limits were not accurate (this is also true for FFAB). This has been corrected and the datasheet number will be changing as shown below:																							
<table border="1"> <thead> <tr> <th>Device Family</th> <th>Change From:</th> <th>Change To:</th> </tr> </thead> <tbody> <tr> <td>TPS63020, TPS63021</td> <td>SLVS916H</td> <td>SLVS916I</td> </tr> </tbody> </table>						Device Family	Change From:	Change To:	TPS63020, TPS63021	SLVS916H	SLVS916I												
Device Family	Change From:	Change To:																					
TPS63020, TPS63021	SLVS916H	SLVS916I																					
 <div style="text-align: right;"> <b>TPS63020, TPS63021</b>  SLVS916I –JULY 2010–REVISED OCTOBER 2019 </div>																							
<b>Changes from Revision H (August 2019) to Revision I</b> <div style="float: right;"><b>Page</b></div> <ul style="list-style-type: none"> <li>• Changed ESD numbers to reflect latest test insights ..... 5</li> <li>• Changed Footnotes in order to reflect wording of latest JEP155 and JEP157 specifications ..... 5</li> <li>• Changed V<sub>FB</sub> naming and description for better readability ..... 6</li> </ul>																							
These changes may be reviewed at the datasheet links provided.																							
<a href="http://www.ti.com/product/TPS63020">http://www.ti.com/product/TPS63020</a>																							
<b>Reason for Change:</b>																							
Continuity of supply and to accurately reflect device characteristics.																							
<b>Anticipated impact on Fit, Form, Function, Quality or Reliability (positive / negative):</b>																							
None.																							
<b>Changes to product identification resulting from this PCN:</b>																							
<b>Fab Site Information:</b>																							
Chip Site	Chip Site Origin Code (20L)	Chip Site Country Code (21L)	Chip Site City																				
FR-BIP-1	TID	DEU	Freising																				
<b>RFAB</b>	<b>RFB</b>	<b>USA</b>	<b>Richardson</b>																				

Sample product shipping label (not actual product label)



**TEXAS INSTRUMENTS**  
MADE IN: Malaysia  
2DC: 20:

MSL 2 / 260C/1 YEAR	SEAL DT
MSL 1 / 235C/UNLIM	03/29/04

OPT:  
ITEM: 39  
**LBL: 5A (L)T0:1750**



G4



(1P) SN74LS07NSR  
(Q) 2000 (D) 0336  
(31T) LOT: 3959047MLA  
(4W) TKY (1T) 7523483SI2  
(P)  
(2P) REV: (V) 0033317  
(20L) CS0: SHE (21L) CC0:USA  
(22L) AS0: MLA (23L) AC0: MYS

#### Product Affected:

##### Group 1: Adding RFAB as an additional site

TLV62080DSGR	TLV62084DSGR	TPS62080DSGR
TLV62080DSGT	TLV62084DSGT	TPS62080DSGT

##### Group 2: Adding RFAB and Datasheet update

TPS63020DSJR	TPS63020DSJT	TPS63021DSJR	TPS63021DSJT
--------------	--------------	--------------	--------------

## Qualification Report

Approve Date 24-August-2019

### Qualification Results

Data Displayed as: Number of lots / Total sample size / Total failed

Type	Test Name / Condition	Duration	Qual Device: TPS63020DSJR	QBS Process Reference: TPS2543QRTE	QBS Package Reference: SN1010017RSAR2	QBS Package Reference: TPS2546RTER
AC	Autoclave, 2 atm, 121C	96 Hours	-	3/231/0	3/231/0	-
ED	Electrical Characterization	Per Datasheet Parameters	Pass	Pass	Pass	-
ELFR	Early Life Failure Rate, 125C	48 Hours	-	3/2400/0	-	-
HAST	Biased HAST, 130C/85%RH	96 Hours	-	3/231/0	-	3/231/0
HBM	ESD – HBM exclude pins VIN, VINA, L1	2000 V	1/3/0	-	-	-
HBM	ESD – HBM all pins	500 V	1/3/0	-	-	-
CDM	ESD – CDM	1500 V	1/3/0	-	-	-
HTOL	Life Test, 150C	300 Hours	-	3/231/0	3/231/0	-
HTSL	High Temp. Storage Bake, 170C	420 Hours	-	-	3/231/0	1/77/0
HTSL	High Temp. Storage Bake, 175C	500 Hours	-	3/135/0	-	-
LU	Latch-up	(per JESD78)	1/6/0	1/6/0	-	-
TC	Temperature Cycle, -55/150C	700 Cycles	-	-	3/231/0	-
TC	Temperature Cycle, -65/150C	500 Cycles	-	3/231/0	-	1/77/0

- QBS: Qual By Similarity

- Qual Device TPS63020DSJR is qualified at LEVEL1-260C

- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable

- The following are equivalent HTOL options based on an activation energy of 0.7eV: 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours

- The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours

- The following are equivalent Temp Cycle options per JESD47: -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: <http://www.ti.com/>

**Green/Pb-free Status:**

Qualified Pb-Free (SMT) and Green

## Qualification Report

Approve Date 25-September-2019

### Qualification Results

Data Displayed as: Number of lots / Total sample size / Total failed

Type	Test Name / Condition	Duration	Qual Device: TLV62080DSGR	QBS Process Reference: TPS2543QRTE	QBS Package Reference: TPS61021DSG	QBS Package Reference: TPS62170DSG
AC	Autoclave, 2 atm, 121C	96 Hours	-	3/231/0	-	-
ED	Electrical Characterization	Per Datasheet Parameters	Pass	Pass	Pass	Pass
ELFR	Early Life Failure Rate, 125C	48 Hours	-	3/2400/0	-	-
HAST	Biased HAST, 130C/85%RH	96 Hours	-	-	-	3/231/0
HAST	Biased HAST, 110C/85%RH	264 Hours	-	3/231/0	3/231/0	-
HBM	ESD - HBM	2000 V	1/3/0	1/3/0	-	-
CDM	ESD - CDM	500 V	1/3/0	1/3/0	-	-
HTOL	Life Test, 150C	300 Hours	-	3/231/0	-	-
HTSL	High Temp. Storage Bake, 170C	420 Hours	-	-	2/90/0	2/90/0
LU	Latch-up	(per JESD78)	1/6/0	1/6/0	-	-
TC	Temperature Cycle, -65/150C	500 Cycles	-	3/231/0	3/231/0	-
UHAST	Unbiased HAST, 130C/85%RH	96 Hours	-	-	3/231/0	3/231/0

- QBS: Qual By Similarity

- Qual Device TLV62080DSGR is qualified at LEVEL2-260C

- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable

- The following are equivalent HTOL options based on an activation energy of 0.7eV: 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours

- The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours

- The following are equivalent Temp Cycle options per JESD47: -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: <http://www.ti.com/>

#### Green/Pb-free Status:

Qualified Pb-Free(SMT) and Green

## Qualification Report

27-September-2019

### Qualification Results

Data Displayed as: Number of lots / Total sample size / Total failed

Type	Test Name / Condition	Duration	Qual Device: TLV62084DSGR	QBS Process Reference: TPS2543QRTE	QBS Package Reference: TPS61021DSG	QBS Package Reference: TPS62170DSG
AC	Autoclave, 2 atm, 121C	96 Hours	-	3/231/0	-	-
ED	Electrical Characterization	Per Datasheet Parameters	Pass	Pass	Pass	Pass
ELFR	Early Life Failure Rate, 125C	48 Hours	-	3/2400/0	-	-
HAST	Biased HAST, 130C/85%RH	96 Hours	-	-	-	3/231/0
HAST	Biased HAST, 110C/85%RH	264 Hours	-	3/231/0	3/231/0	-
HBM	ESD - HBM	2000 V	1/3/0	1/3/0	-	-
CDM	ESD - CDM	500 V	1/3/0	1/3/0	-	-
HTOL	Life Test, 150C	300 Hours	-	3/231/0	-	-
HTSL	High Temp. Storage Bake, 170C	420 Hours	-	-	2/90/0	2/90/0
LU	Latch-up	(per JESD78)	1/6/0	1/6/0	-	-
TC	Temperature Cycle, -65/150C	500 Cycles	-	3/231/0	3/231/0	-
UHAST	Unbiased HAST, 130C/85%RH	96 Hours	-	-	3/231/0	3/231/0

- QBS: Qual By Similarity

- Qual Device TLV62084DSGR is qualified at LEVEL2-260C

- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable

- The following are equivalent HTOL options based on an activation energy of 0.7eV: 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours

- The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours

- The following are equivalent Temp Cycle options per JESD47: -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: <http://www.ti.com/>

#### Green/Pb-free Status:

Qualified Pb-Free(SMT) and Green

For questions regarding this notice, e-mails can be sent to the contacts shown below or your local Field Sales Representative.

Location	E-Mail
USA	<a href="mailto:PCNAmericasContact@list.ti.com">PCNAmericasContact@list.ti.com</a>
Europe	<a href="mailto:PCNEuropeContact@list.ti.com">PCNEuropeContact@list.ti.com</a>
Asia Pacific	<a href="mailto:PCNAsiaContact@list.ti.com">PCNAsiaContact@list.ti.com</a>
WW PCN Team	<a href="mailto:PCN_ww_admin_team@list.ti.com">PCN_ww_admin_team@list.ti.com</a>

## IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES “AS IS” AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, or other requirements. These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale ([www.ti.com/legal/termsofsale.html](http://www.ti.com/legal/termsofsale.html)) or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.